Se	arch	Not	es



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/799,757	NAKANO, JUN	
Examiner	Art Unit	
LaTanya Bibbins	2627	

SEARCHED			
Class	Subclass	Date	Examiner
369 .	44.27	2/7/2007	LB
369	44.29	2/7/2007	LB
369	53.28	2/7/2007	LB
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INTERFERENCE SEARCHED		
Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Databases Searched: USPAT, USPGPub, EPO, & JPO (see search history attached)	2/7/2007	LB
Inventor Name Search	2/4/2007	LB
Non-Patent Literature Search (including Google and IEEE Xplore)	2/7/2007	LB
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